

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/690,463	CHENG, JYH-NAN
Examiner	Art Unit	
TAN N. TRAN	2826	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	173	05/05	TT
341			
344			
355			
365			
408			